

RF Power Field Effect Transistors

N-Channel Enhancement-Mode Lateral MOSFETs

Designed for WiMAX base station applications with frequencies up to 3800 MHz. Suitable for WiMAX, WiBro, BWA, and OFDM multicarrier Class AB and Class C amplifier applications.

- Typical WiMAX Performance: $V_{DD} = 30$ Volts, $I_{DQ} = 450$ mA, $P_{out} = 8$ Watts Avg., $f = 3400$ -3600 MHz, 802.16d, 64 QAM $3/4$, 4 bursts, 7 MHz Channel Bandwidth, Input Signal PAR = 9.5 dB @ 0.01% Probability on CCDF.
Power Gain — 14 dB
Drain Efficiency — 15.6%
Device Output Signal PAR — 8.4 dB @ 0.01% Probability on CCDF
ACPR @ 5.25 MHz Offset — -49 dBc in 0.5 MHz Channel Bandwidth
- Capable of Handling 10:1 VSWR, @ 32 Vdc, 3500 MHz, 40 Watts CW Peak Tuned Output Power
- P_{out} @ 1 dB Compression Point ≥ 40 Watts CW

Features

- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Internally Matched for Ease of Use
- Integrated ESD Protection
- Greater Negative Gate-Source Voltage Range for Improved Class C Operation
- RoHS Compliant
- In Tape and Reel. R3 Suffix = 250 Units per 32 mm, 13 inch Reel.

MRF7S38040HR3
MRF7S38040HSR3

3400-3600 MHz, 8 W AVG., 30 V
WiMAX
LATERAL N-CHANNEL
RF POWER MOSFETs

CASE 465I-02, STYLE 1
NI-400-240
MRF7S38040HR3

CASE 465J-02, STYLE 1
NI-400S-240
MRF7S38040HSR3

Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	-0.5, +65	Vdc
Gate-Source Voltage	V_{GS}	-6.0, +10	Vdc
Operating Voltage	V_{DD}	32, +0	Vdc
Storage Temperature Range	T_{stg}	- 65 to +150	°C
Case Operating Temperature	T_C	150	°C
Operating Junction Temperature (1,2)	T_J	225	°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value (2,3)	Unit
Thermal Resistance, Junction to Case Case Temperature 96°C, 39 W CW Case Temperature 75°C, 8 W CW	$R_{\theta JC}$	0.78 0.83	°C/W

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at <http://www.freescale.com/rf>. Select Tools/Software/Application Software/Calculators to access the MTTF calculators by product.
3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	1C (Minimum)
Machine Model (per EIA/JESD22-A115)	A (Minimum)
Charge Device Model (per JESD22-C101)	IV (Minimum)

Table 4. Electrical Characteristics ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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Off Characteristics

Zero Gate Voltage Drain Leakage Current ($V_{DS} = 65\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$)	I_{DSS}	—	—	10	μAdc
Zero Gate Voltage Drain Leakage Current ($V_{DS} = 28\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$)	I_{DSS}	—	—	1	μAdc
Gate-Source Leakage Current ($V_{GS} = 5\text{ Vdc}$, $V_{DS} = 0\text{ Vdc}$)	I_{GSS}	—	—	1	μAdc

On Characteristics

Gate Threshold Voltage ($V_{DS} = 10\text{ Vdc}$, $I_D = 124\text{ }\mu\text{Adc}$)	$V_{GS(th)}$	1.2	2	2.7	Vdc
Gate Quiescent Voltage ($V_{DD} = 28\text{ Vdc}$, $I_D = 450\text{ mAdc}$, Measured in Functional Test)	$V_{GS(Q)}$	2	2.7	3.5	Vdc
Drain-Source On-Voltage ($V_{GS} = 10\text{ Vdc}$, $I_D = 1.15\text{ Adc}$)	$V_{DS(on)}$	0.1	0.21	0.3	Vdc

Dynamic Characteristics ⁽¹⁾

Reverse Transfer Capacitance ($V_{DS} = 28\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$)	C_{rss}	—	0.4	—	pF
Output Capacitance ($V_{DS} = 28\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$)	C_{oss}	—	229	—	pF
Input Capacitance ($V_{DS} = 28\text{ Vdc}$, $V_{GS} = 0\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz)	C_{iss}	—	268	—	pF

Functional Tests (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 30\text{ Vdc}$, $I_{DQ} = 450\text{ mA}$, $P_{out} = 8\text{ W Avg.}$, $f = 3400\text{ MHz}$ and $f = 3600\text{ MHz}$, WiMAX Signal, 802.16d, 7 MHz Channel Bandwidth, 64 QAM $3/4$, 4 Bursts, PAR = 9.5 dB @ 0.01% Probability on CCDF. ACPR measured in 0.5 MHz Channel Bandwidth @ $\pm 5.25\text{ MHz}$ Offset.

Power Gain	G_{ps}	12	14	16	dB
Drain Efficiency	η_D	14	15.6	24	%
Output Peak-to-Average Ratio @ 0.01% Probability on CCDF	PAR	7.3	8.4	—	dB
Adjacent Channel Power Ratio	ACPR	—	-49	-46	dBc
Input Return Loss	IRL	—	-10	-5	dB

1. Part internally matched both on input and output.

(continued)

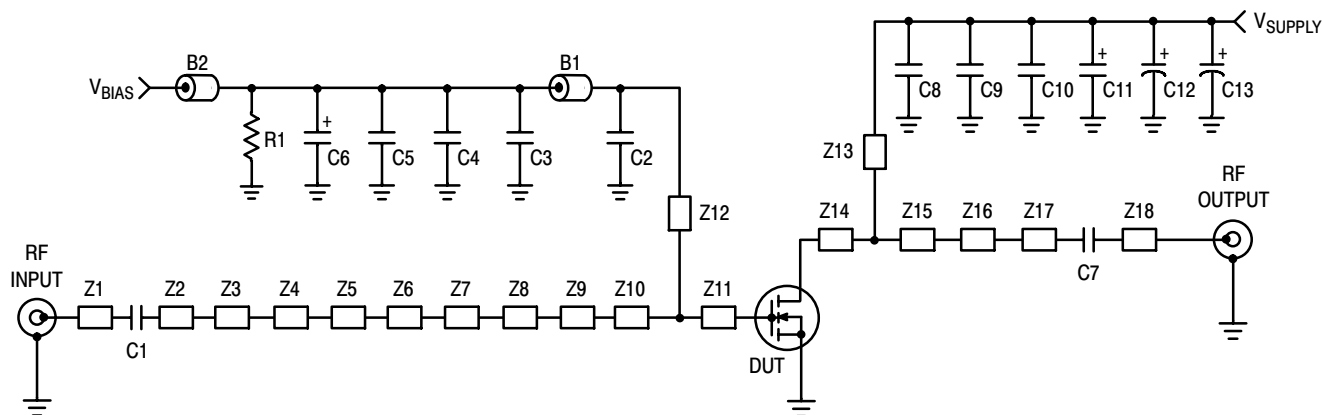
Table 4. Electrical Characteristics ($T_C = 25^\circ\text{C}$ unless otherwise noted) (continued)

Characteristic	Symbol	Min	Typ	Max	Unit
Typical Performances OFDM Signal (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 30\text{ Vdc}$, $I_{DQ} = 450\text{ mA}$, $P_{out} = 8\text{ W Avg.}$, $f = 3400\text{ MHz}$ and $f = 3600\text{ MHz}$, WiMAX Signal, OFDM Single-Carrier, 7 MHz Channel Bandwidth, 64 QAM $3/4$, 4 Bursts, PAR = 9.5 dB @ 0.01% Probability on CCDF.					
Mask System Type G @ $P_{out} = 8\text{ W Avg.}$ Point B at 3.5 MHz Offset Point C at 5 MHz Offset Point D at 7.4 MHz Offset Point E at 14 MHz Offset Point F at 17.5 MHz Offset	Mask	—	-27 -38 -42 -60 -60	—	dBc
Relative Constellation Error @ $P_{out} = 8\text{ W Avg.}$ ⁽¹⁾	RCE	—	-34	—	dB
Error Vector Magnitude ⁽¹⁾ (Typical EVM Performance @ $P_{out} = 8\text{ W Avg.}$ with OFDM 802.16d Signal Call)	EVM	—	2.0	—	% rms

Typical Performances (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 30\text{ Vdc}$, $I_{DQ} = 450\text{ mA}$, 3400-3600 MHz Bandwidth

Video Bandwidth @ 44 W PEP P_{out} where IM3 = -30 dBc (Tone Spacing from 100 kHz to VBW) $\Delta\text{IMD3} = \text{IMD3 @ VBW frequency} - \text{IMD3 @ 100 kHz} < 1\text{ dBc}$ (both sidebands)	VBW	—	30	—	MHz
Gain Flatness in 200 MHz Bandwidth @ $P_{out} = 8\text{ W Avg.}$	G_F	—	0.87	—	dB
Average Deviation from Linear Phase in 200 MHz Bandwidth @ $P_{out} = 40\text{ W CW}$	Φ	—	1.62	—	°
Average Group Delay @ $P_{out} = 40\text{ W CW}$, $f = 3500\text{ MHz}$	Delay	—	1.65	—	ns
Part-to-Part Insertion Phase Variation @ $P_{out} = 40\text{ W CW}$, $f = 3500\text{ MHz}$, Six Sigma Window	$\Delta\Phi$	—	22.9	—	°
Gain Variation over Temperature (-30°C to +85°C)	ΔG	—	0.027	—	dB/°C
Output Power Variation over Temperature (-30°C to +85°C)	ΔP_{1dB}	—	0.121	—	dBm/°C

1. $RCE = 20\text{Log}(EVM/100)$



Z1	0.822" x 0.084" Microstrip	Z10, Z11	0.061" x 0.322" Microstrip
Z2	0.454" x 0.386" Microstrip	Z12	0.694" x 0.050" Microstrip
Z3	0.950" x 0.220" Microstrip	Z13	0.268" x 0.071" Microstrip
Z4	0.023" x 0.358" Microstrip	Z14	0.095" x 0.674" Microstrip
Z5	0.400" x 0.379" Microstrip	Z15	0.359" x 0.674" Microstrip
Z6	0.230" x 0.358" Microstrip	Z16	0.640" x 0.241" Microstrip
Z7	0.100" x 0.358" x 0.104" Taper	Z17	0.410" x 0.084" Microstrip
Z8	0.214" x 0.104" Microstrip	Z18	0.726" x 0.084" Microstrip
Z9	0.050" x 0.213" x 0.322" Taper	PCB	Arlon CuClad 250GX-0300-55-22, 0.030", $\epsilon_r = 2.55$

Figure 1. MRF7S38040HR3(HSR3) Test Circuit Schematic

Table 5. MRF7S38040HR3(HSR3) Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
B1, B2	Chip Ferrite Beads	2508051107Y0	Fair-Rite
C1, C2, C7, C8	2.7 pF Chip Capacitors	ATC100B2R7BT500XT	ATC
C3, C9	36 pF Chip Capacitors	ATC100B360BT500XT	ATC
C4, C10	0.01 μ F, 100 V Chip Capacitors	C1825C103J1RAC	Kemet
C5	1K pF Chip Capacitor	ATC100B102BT50XT	ATC
C6	10 μ F, 35 V Tantalum Capacitor	T491C106K035AT	Kemet
C11	22 μ F, 35 V Tantalum Capacitor	T491C226K035AT	Kemet
C12	470 μ F, 63 V Electrolytic Capacitor	EKME630ELL471MK25S	Multicomp
C13	100 μ F, 50 V Electrolytic Capacitor	MCHT101M1HB-1017-RH	Multicomp
R1	180 K Ω , 1/4 W Chip Resistor	CRCW12061803FKEA	Vishay

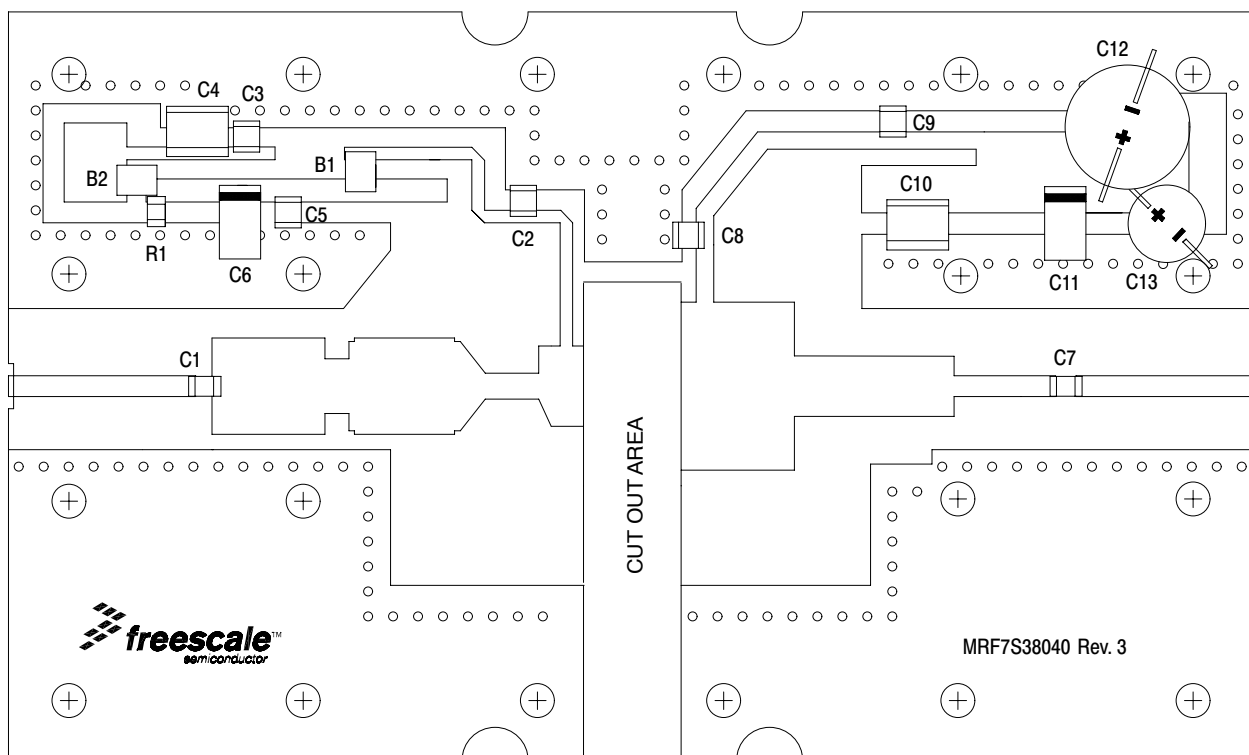


Figure 2. MRF7S38040HR3(HSR3) Test Circuit Component Layout

TYPICAL CHARACTERISTICS

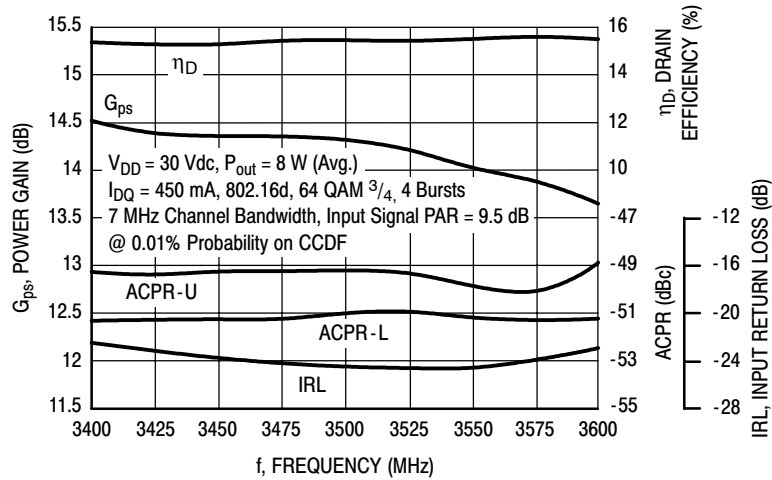


Figure 3. WiMAX Broadband Performance @ $P_{out} = 8$ Watts Avg.

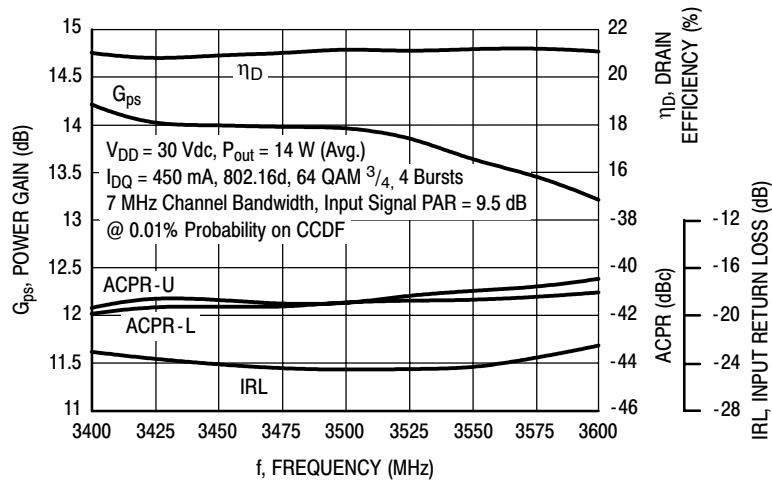


Figure 4. WiMAX Broadband Performance @ $P_{out} = 14$ Watts Avg.

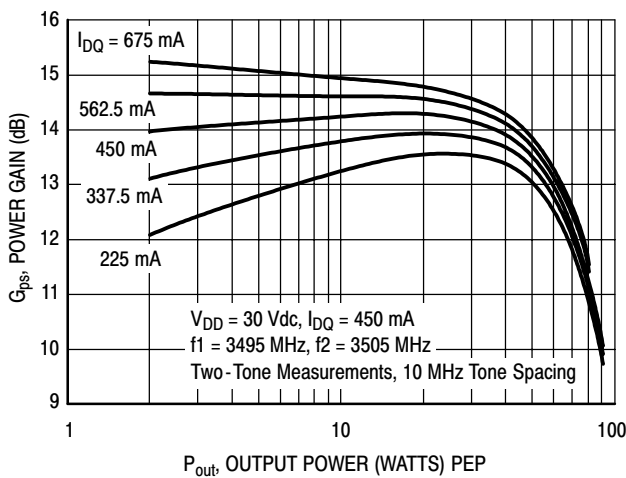


Figure 5. Two-Tone Power Gain versus Output Power

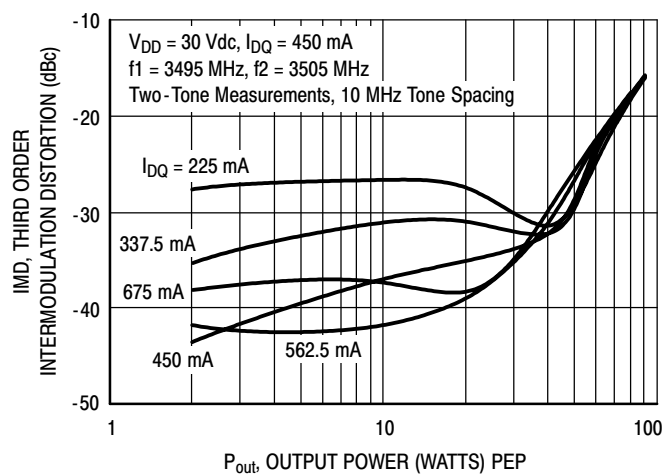


Figure 6. Third Order Intermodulation Distortion versus Output Power

TYPICAL CHARACTERISTICS

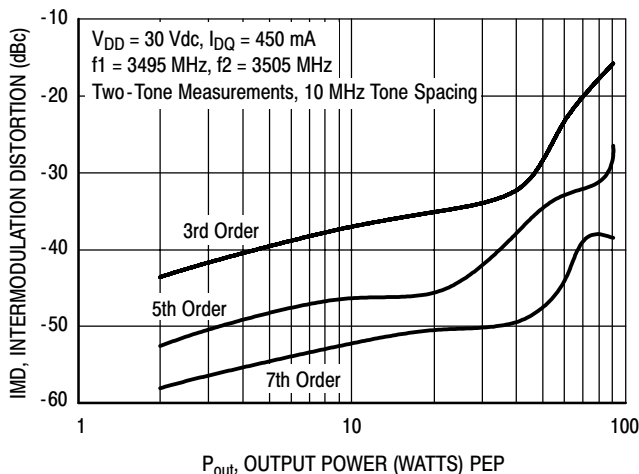


Figure 7. Intermodulation Distortion Products versus Output Power

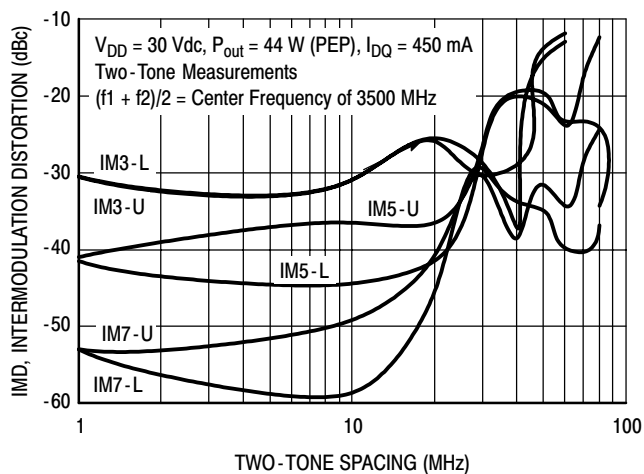


Figure 8. Intermodulation Distortion Products versus Tone Spacing

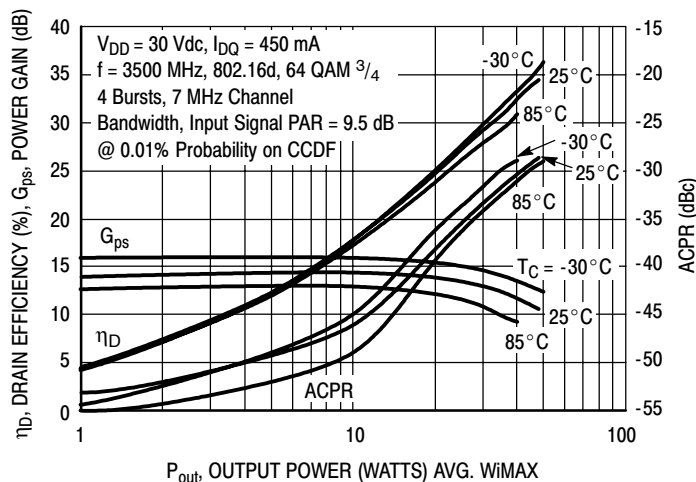


Figure 9. WiMAX, ACPR, Power Gain and Drain Efficiency versus Output Power

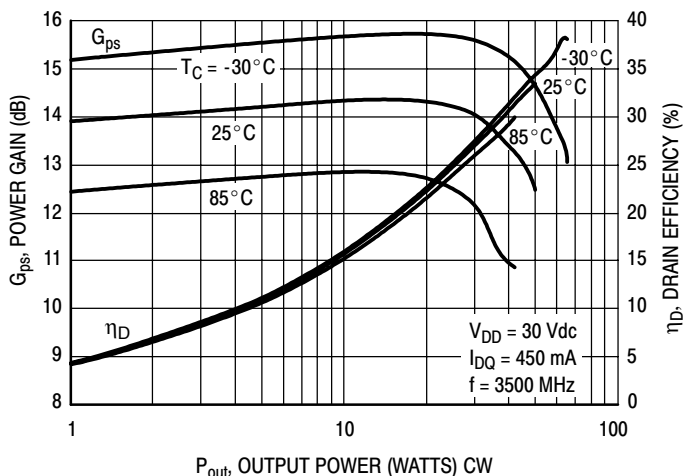


Figure 10. Power Gain and Drain Efficiency versus CW Output Power

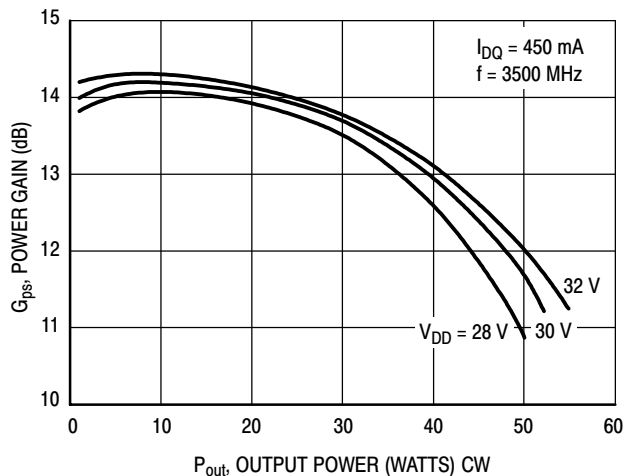
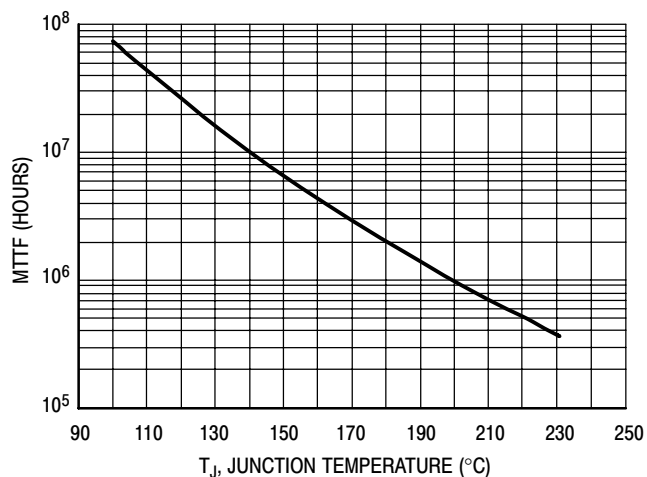


Figure 11. Power Gain versus Output Power

TYPICAL CHARACTERISTICS



This above graph displays calculated MTTF in hours when the device is operated at $V_{DD} = 30$ Vdc, $P_{out} = 8$ W Avg., and $\eta_D = 15.6\%$.

MTTF calculator available at <http://www.freescale.com/rf>. Select Tools/Software/Application Software/Calculators to access the MTTF calculators by product.

Figure 12. MTTF versus Junction Temperature

WIMAX TEST SIGNAL

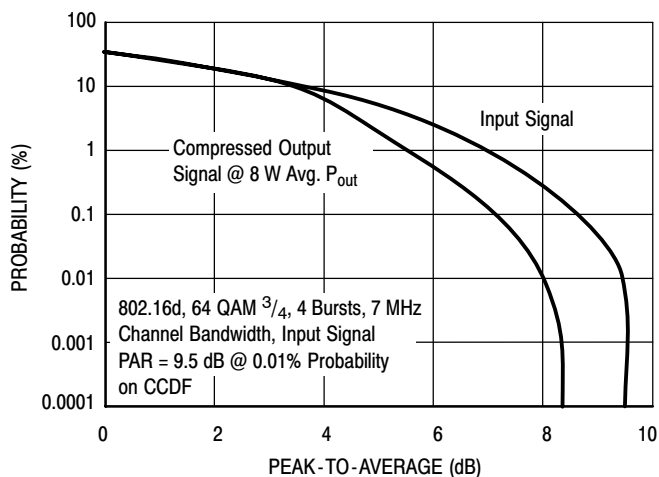


Figure 13. OFDM 802.16d Test Signal

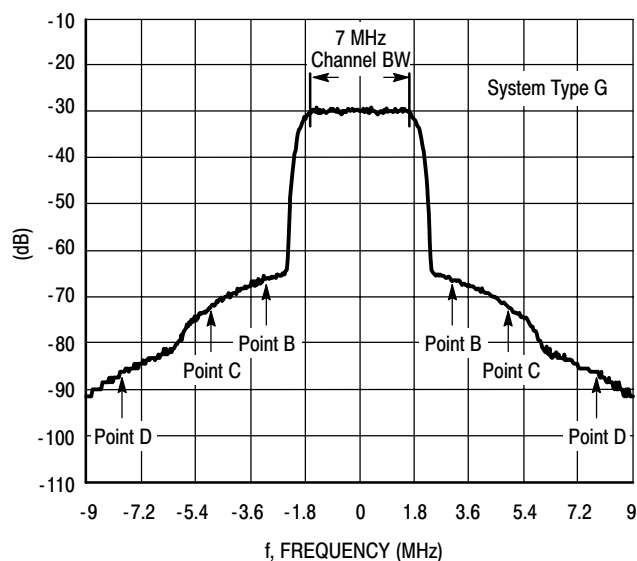
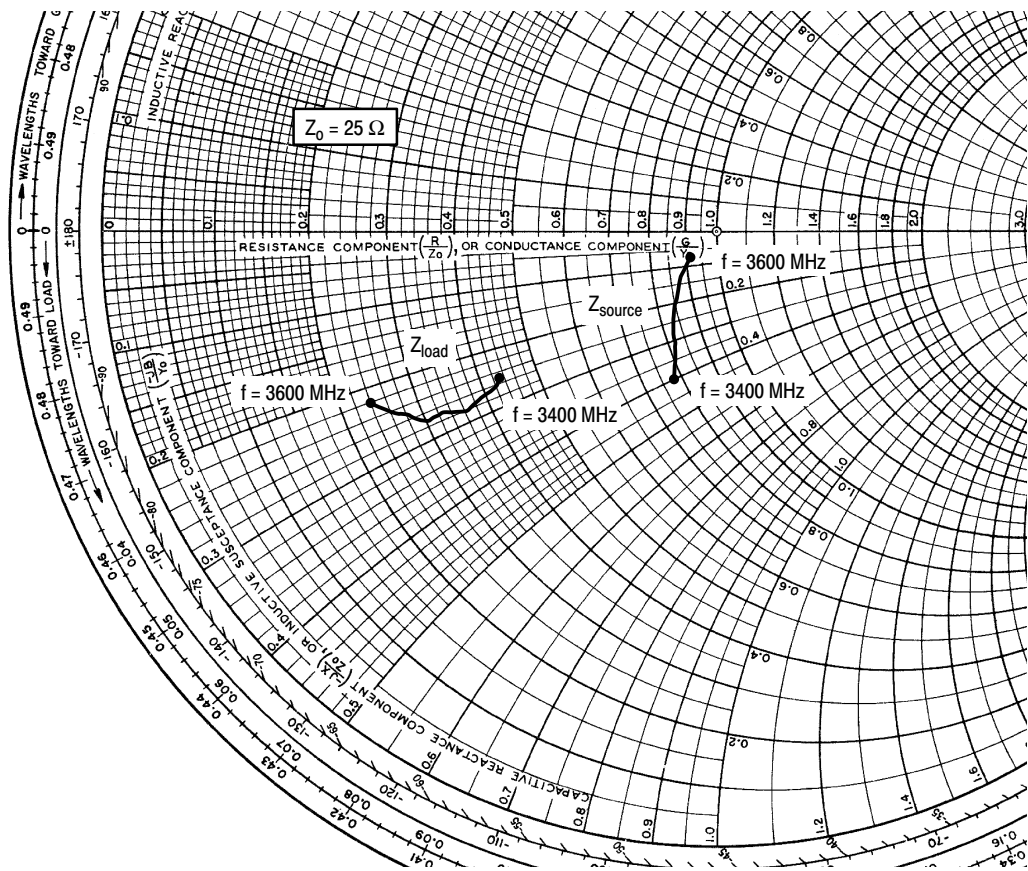


Figure 14. WiMAX Spectrum Mask Specifications



$V_{DD} = 30 \text{ Vdc}$, $I_{DQ} = 450 \text{ mA}$, $P_{out} = 8 \text{ W Avg.}$

f MHz	Z_{source} Ω	Z_{load} Ω
3400	19.57 - j9.98	10.66 - j6.30
3425	20.02 - j9.03	10.41 - j6.55
3450	20.33 - j8.18	9.85 - j6.83
3475	20.45 - j7.42	9.06 - j6.91
3500	20.78 - j6.65	8.30 - j6.84
3525	21.07 - j5.79	7.57 - j6.64
3550	21.45 - j4.55	6.91 - j6.31
3575	22.03 - j3.26	6.39 - j5.92
3600	22.73 - j2.06	5.97 - j5.48

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

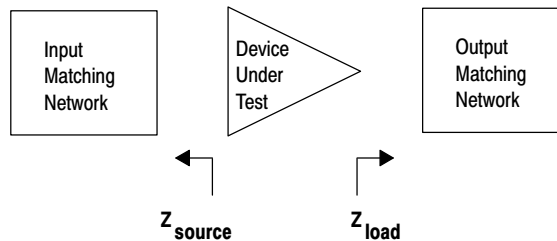
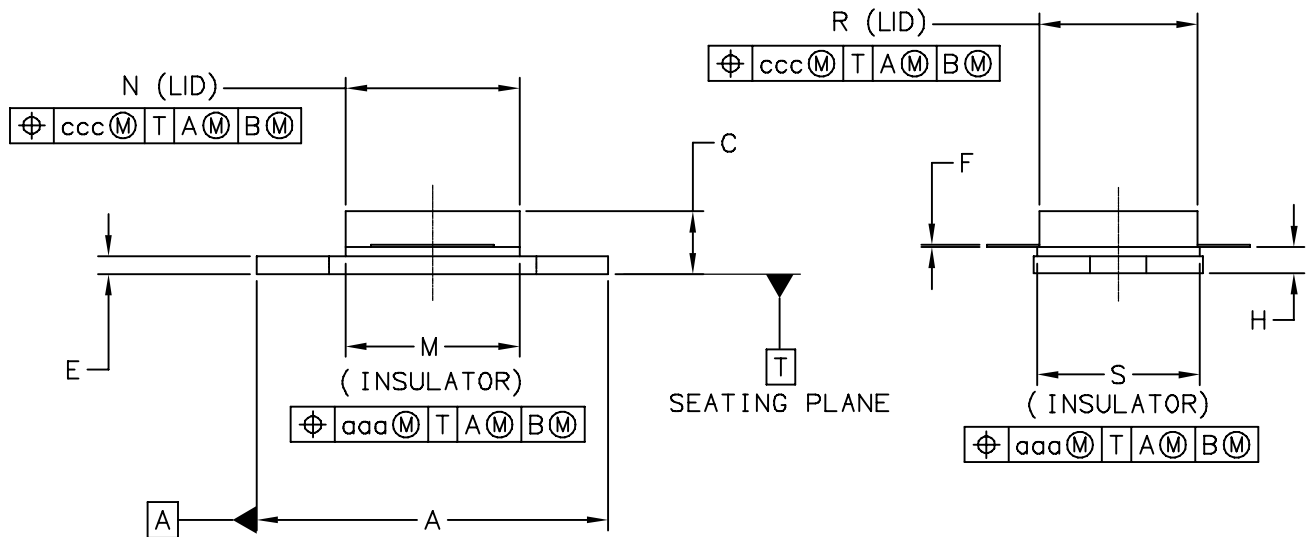
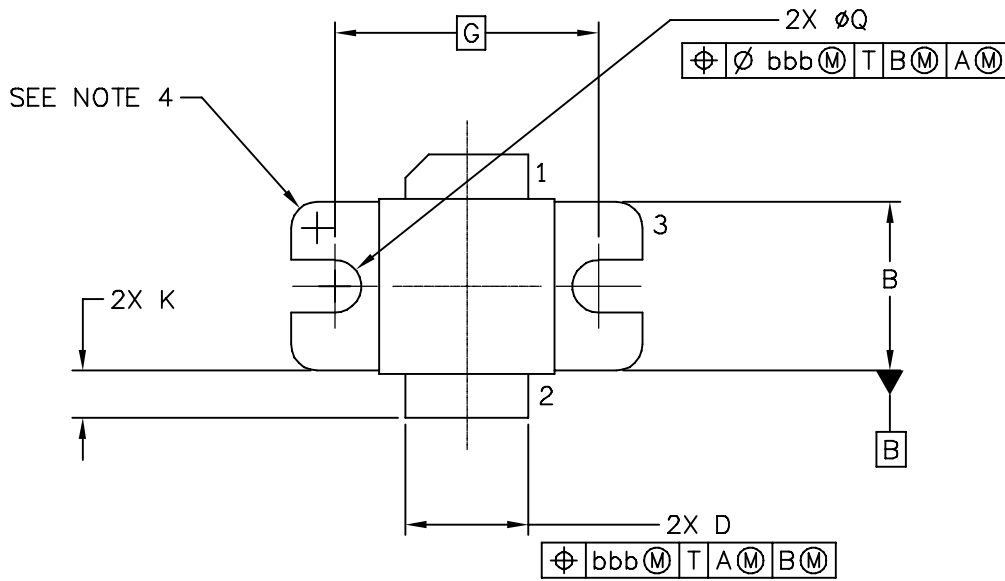


Figure 15. Series Equivalent Source and Load Impedance

PACKAGE DIMENSIONS



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TITLE: NI-400-240			DOCUMENT NO: 98ASA10730D		REV: B
			CASE NUMBER: 465I-02		09 MAY 2006
			STANDARD: NON-JEDEC		

NOTES:

1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DIMENSION H IS MEASURED .030 (0.762) AWAY FROM PACKAGE BODY.
4. INFORMATION ONLY:
CORNER BREAK (4X) TO BE .060±.005 (1.52±0.13) RADIUS OR
.06±.005 (1.52±0.13) × 45° CHAMFER.

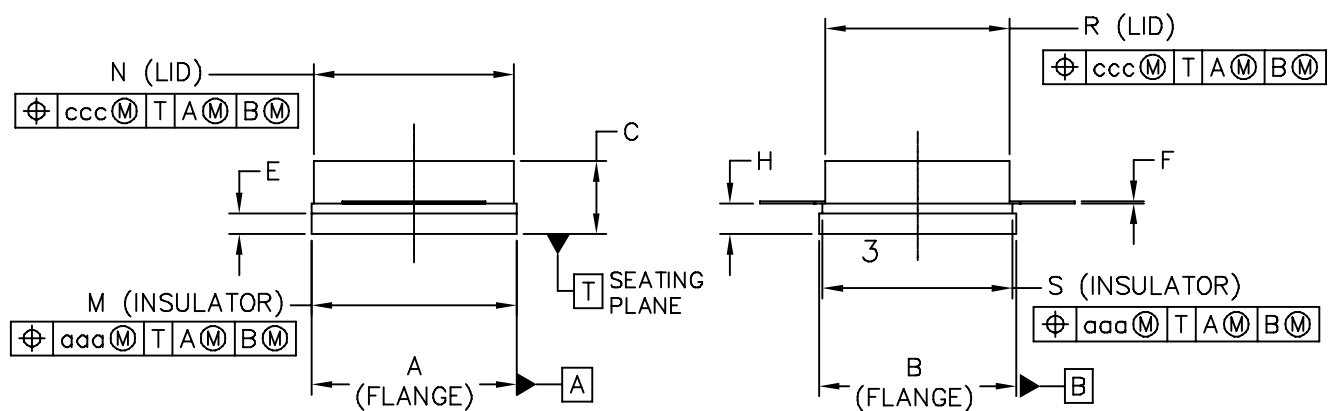
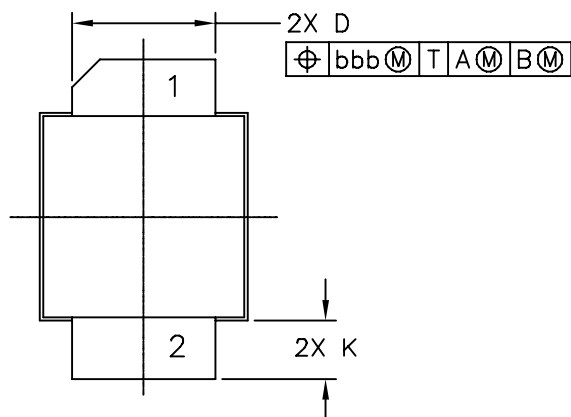
STYLE 1

PIN 1: DRAIN
PIN 2: GATE
PIN 3: SOURCE

STYLE 2

PIN 1: GATE
PIN 2: DRAIN
PIN 3: SOURCE

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
A	.795	.805	20.19	20.44	R	.355	.365	9.02	9.27
B	.380	.390	9.65	9.91	S	.365	.375	9.27	9.53
C	.125	.163	3.17	4.14					
D	.275	.285	6.98	7.24	aaa	.005		0.127	
E	.035	.045	0.89	1.14	bbb	.010		0.254	
F	.004	.006	0.10	0.15	ccc	.015		0.381	
G	.600 BSC		15.24 BSC						
H	.057	.067	1.45	1.70					
K	.0995	.1295	2.53	3.29					
M	.395	.405	10.03	10.29					
N	.385	.395	9.78	10.03					
Q	ø.120	ø.130	ø3.05	ø3.30					
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		STANDARD: NON-JEDEC		

NOTES:

1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DIMENSION H IS MEASURED .030 (0.762) AWAY FROM PACKAGE BODY

STYLE 1:

- PIN 1 - DRAIN
- 2 - GATE
- 3 - SOURCE

STYLE 2:

- PIN 1 - GATE
- 2 - DRAIN
- 3 - SOURCE

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
A	.395	.405	10.03	10.29	aaa	.005		0.127	
B	.380	.390	9.65	9.91	bbb	.010		0.254	
C	.125	.163	3.18	4.14	ccc	.015		0.381	
D	.275	.285	6.98	7.24					
E	.035	.045	0.89	1.14					
F	.004	.006	0.10	0.15					
H	.057	.067	1.45	1.70					
K	.0995	.1295	2.53	3.29					
M	.395	.405	10.03	10.29					
N	.385	.395	9.78	10.03					
R	.355	.365	9.02	9.27					
S	.365	.375	9.27	9.53					
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					CASE NUMBER: 465J-02			09 MAY 2006	
					STANDARD: NON-JEDEC				

PRODUCT DOCUMENTATION

Refer to the following documents to aid your design process.

Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Aug. 2007	• Initial Release of Data Sheet

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